# **Power MOSFET**

20 V, +0.63/-0.82 A, SC-88 Complementary, ESD Protected

#### Features

- Complementary N- and P-Channel MOSFET
- Small Size Dual SC-88 Package
- Reduced Gate Charge to Improve Switching Response
- Independently Connected Devices to Provide Design Flexibility
- This is a Pb-Free Device

### Applications

- DC-DC Conversion Circuits
- Load/Power Switching with Level Shift

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Pa	Symbol	Value	Unit			
Drain-to-Source Voltage			V <sub>DSS</sub>	20	V	
Gate-to-Source Vol	tage		V <sub>GS</sub>	±12	V	
N-Channel Continuous Drain	Stoody State	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	0.63	А	
Current (Note 1)	Steady State	T <sub>A</sub> = 85°C		0.46		
	t ≤ 5 s	T <sub>A</sub> = 25°C		0.72		
P-Channel	$T_A = 25^{\circ}C$		۱ <sub>D</sub>	-0.82	А	
Continuous Drain Current (Note 1)	Steady State	T <sub>A</sub> = 85°C		-0.59		
	t ≤ 5 s	$T_A = 25^{\circ}C$		-0.93		
Power Dissipation			PD	0.27	W	
(Note 1)	t ≤ 5 s	T <sub>A</sub> = 25°C		0.35		
Pulsed Drain	N-Ch	to 10.00	I <sub>DM</sub>	1.3	А	
Current	P-Ch	tp = 10 μs		-1.6		
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	
Source Current (Body Diode)			۱ <sub>S</sub>	0.46	А	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	460	°C/W
Junction-to-Ambient – t $\leq$ 5 s (Note 1)	$R_{\theta JA}$	357	
Junction-to-Lead (Drain) - Steady State (Note 1)	$R_{\theta JL}$	226	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

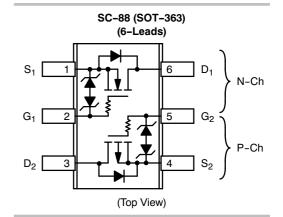
 Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



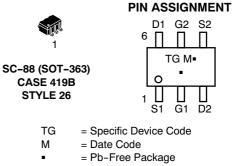
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#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
N-Ch	375 mΩ @ 4.5 V	0.63 A
20 V	445 mΩ @ 2.5 V	0.03 A
P-Ch	300 mΩ @ -4.5 V	-0.82 A
-20 V	500 mΩ @ -2.5 V	-0.02 A



MARKING DIAGRAM &



(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

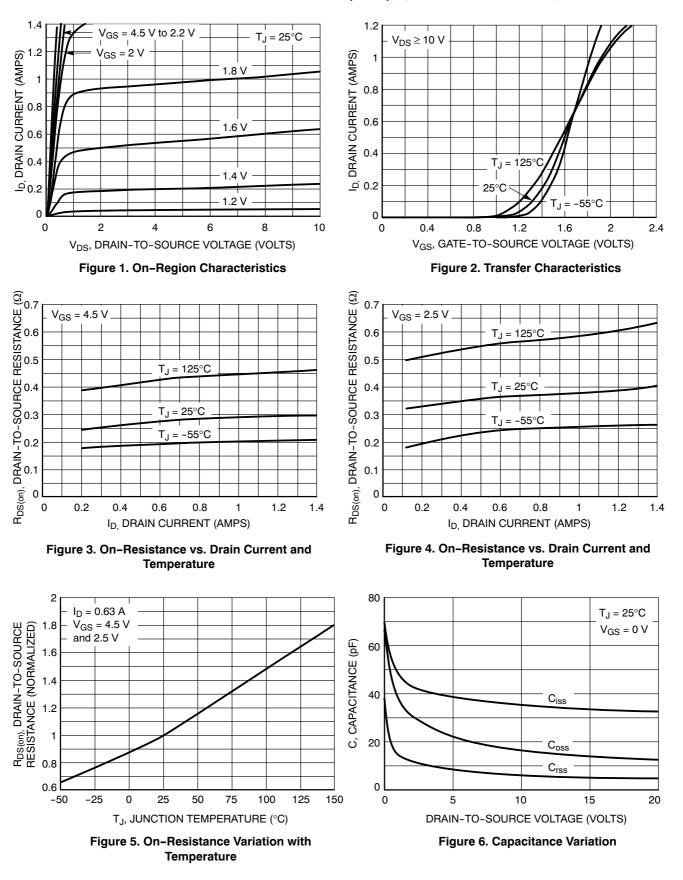
Device	Package	Shipping†
NTJD3158CT1G	SC-88 (Pb-Free)	3000/Tape & Reel
NTJD3158CT4G	SC-88 (Pb-Free)	10000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

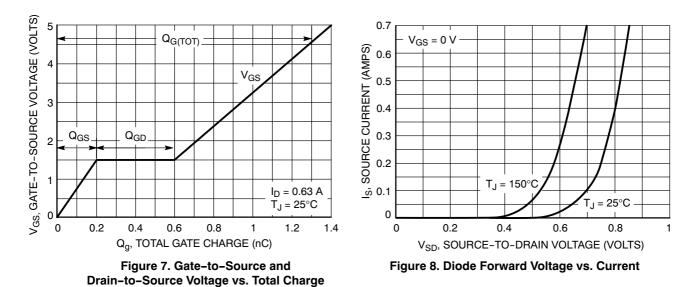
Parameter	Symbol	N/P	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS (Note 3)								
Drain-to-Source	V <sub>(BR)DSS</sub>	Ν	V <sub>GS</sub> = 0 V	I <sub>D</sub> = 250 μA	20			V
Breakdown Voltage		Р	VGS = 0 V	I <sub>D</sub> = -250 μA	-20			
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>					22		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	Ν	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1	6 V			1.0	μΑ
		Р	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -1	6 V			1.0	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	Ν	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±1	12 V			±10	μΑ
		Р	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±4	.5 V			±1.0	1
		Р	$V_{DS} = 0 V, V_{GS} = \pm 1$	12 V		6.0		1
ON CHARACTERISTICS (Note 2)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	Ν	I <sub>D</sub> = 250 μA		0.6		1.5	V
		Р	I <sub>D</sub> = -250 μA		-0.45			
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	Ν	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 0.6$	63 A		290	375	mΩ
		Р	$V_{GS}$ = -4.5 V, I <sub>D</sub> = -0.88 A			255	300	
		Ν	$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 0.4$	40 A		360	445	
		Р	$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -0$	.71 A		345	500	
Forward Transconductance	<b>9</b> FS	Ν	$V_{DS} = 4.0 \text{ V}, \text{ I}_{D} = 0.6 \text{ V}$	63 A		2.0		S
		Р	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -0.88 A			3.0		
CHARGES, CAPACITANCES AND	GATE RESIS	TANCE		-	-		-	
Input Capacitance	C <sub>ISS</sub>	Ν		V <sub>DS</sub> = 20 V		33	46	pF
	C <sub>OSS</sub>	Р	f = 1 MHz, V <sub>GS</sub> = 0 V	$V_{DS} = -20 V$		155		
Output Capacitance		Ν		V <sub>DS</sub> = 20 V		13	22	
		Р		V <sub>DS</sub> = -20 V		25		
Reverse Transfer Capacitance	C <sub>RSS</sub>	Ν		V <sub>DS</sub> = 20 V		2.8	5.0	
		Р		$V_{DS} = -20 V$		18		
Total Gate Charge	Q <sub>G(TOT)</sub>	Ν	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I	=		1.3	3.0	nC
		Р	$V_{GS}$ = -4.5 V, $V_{DS}$ = -15 V,			2.2		
Gate-to-Source Charge	$Q_{GS}$	Ν	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I			0.2		
		Р	$V_{GS}$ = -4.5 V, $V_{DS}$ = -15 V,			0.5		
Gate-to-Drain Charge	$Q_{GD}$	Ν	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I			0.4		
		Р	$V_{GS}$ = -4.5 V, $V_{DS}$ = -10 V,	I <sub>D</sub> = -0.88 A		0.65		
SWITCHING CHARACTERISTICS (							1	1
Turn-On Delay Time	t <sub>d(ON)</sub>	N				83		ns
Rise Time	t <sub>r</sub>		$V_{GS} = 4.5 V, V_{DD} = 1$			227		
Turn-Off Delay Time	t <sub>d(OFF)</sub>		$I_D = 0.5 \text{ A}, \text{ R}_G = 20 \Omega$			786		
Fall Time	t <sub>f</sub>					506		ļ
Turn-On Delay Time	t <sub>d(ON)</sub>	Р	$V_{GS}$ = -4.5 V, $V_{DD}$ = -10 V, I <sub>D</sub> = -0.5 A, R <sub>G</sub> = 20 $\Omega$			5.8		ļ
Rise Time	t <sub>r</sub>					6.5		
Turn-Off Delay Time	t <sub>d(OFF)</sub>					13.5		
	t <sub>f</sub>					3.5		
DRAIN-SOURCE DIODE CHARAC		N				0.70	4 4	11
Forward Diode Voltage	V <sub>SD</sub>	N P	$V_{GS}$ = 0 V, $T_{J}$ = 25°C	$I_{\rm S} = 0.23 \rm A$		0.76	1.1	V
		-	•	I <sub>S</sub> = -0.48 A		-0.8	-1.2	
	N V <sub>GS</sub> = 0 V, T <sub>J</sub> = 1		V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C	I <sub>S</sub> = 0.23 A		0.63		-
		Р		I <sub>S</sub> = -0.48 A		-0.66		

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

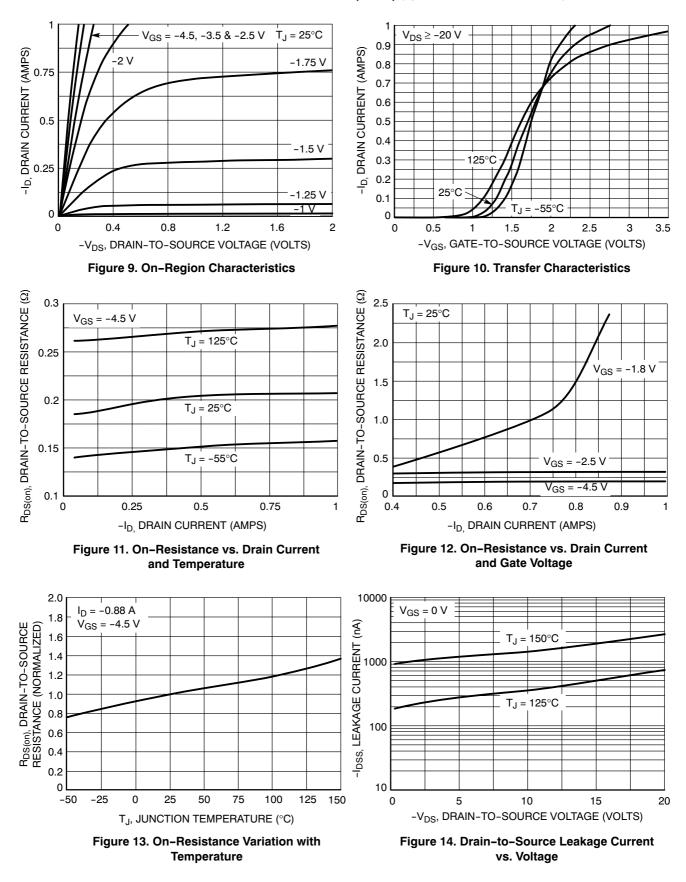


### TYPICAL PERFORMANCE CURVES (N-Ch) (T<sub>J</sub> = 25°C unless otherwise noted)

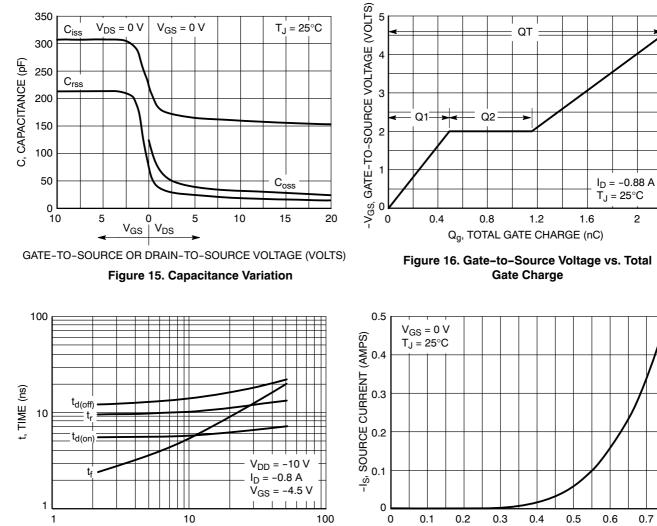
## TYPICAL PERFORMANCE CURVES (N-Ch) (T<sub>J</sub> = 25°C unless otherwise noted)



### TYPICAL PERFORMANCE CURVES (P-Ch) (T<sub>J</sub> = 25°C unless otherwise noted)



# TYPICAL PERFORMANCE CURVES (P–Ch) ( $T_J$ = 25°C unless otherwise noted)



R<sub>G</sub>, GATE RESISTANCE (OHMS)

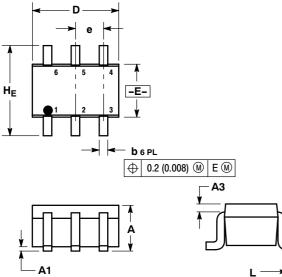
Figure 17. Resistive Switching Time Variation vs. Gate Resistance

Figure 18. Diode Forward Voltage vs. Current

-V<sub>SD</sub>, SOURCE-TO-DRAIN VOLTAGE (VOLTS)

#### PACKAGE DIMENSIONS

SC-88/SC70-6/SOT-363 CASE 419B-02 **ISSUE W** 



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982.

CONTROLLING DIMENSION: INCH 2.

3. 419B-01 OBSOLETE, NEW STANDARD 419B-02.

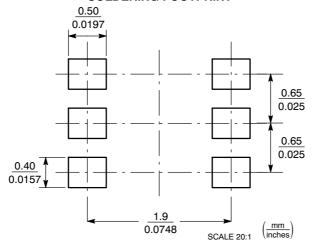
	MIL	LIMETE	ERS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.80	0.95	1.10	0.031	0.037	0.043	
A1	0.00	0.05	0.10	0.000	0.002	0.004	
A3	0.20 REF			0.008 REF			
b	0.10	0.21	0.30	0.004	0.008	0.012	
С	0.10	0.14	0.25	0.004	0.005	0.010	
D	1.80	2.00	2.20	0.070	0.078	0.086	
Е	1.15	1.25	1.35	0.045	0.049	0.053	
е	0.65 BSC			0.026 BSC			
L	0.10	0.20	0.30	0.004	0.008	0.012	
HF	2.00	2.10	2.20	0.078	0.082	0.086	

STYLE 26: PIN 1. SOURCE 1 2. GATE 1 3. DRAIN 2 4 SOURCE 2

5. GATE 2 6. DRAIN 1

SOLDERING FOOTPRINT\*

С



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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